

Notice of References Cited	Application/Control No. 10/605,234	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Khiem D. Nguyen	Art Unit 2823	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,122,439	10-2006	Kwon et al.	438/386
*	C	US-2005/0181557	08-2005	Jakschik et al.	438/246
*	D	US-6,667,503	12-2003	Koike et al.	257/301
*	E	US-6,605,838	08-2003	Mandelman et al.	257/305
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	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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